

# 1 Mb High Speed Quad SPI MRAM

### **FEATURES**

- High bandwidth Read and Write at 52MB/sec
- Quad I/O with the use of dual purpose pins to maintain a low pin count
- Operates in both standard, single SPI mode and high speed guad SPI mode
- Fast guad Read and Write with guad address input and guad I/O
- Intended for next generation RAID controllers, server system logs, storage device buffers, and embedded system data and program memory
- Data is non-volatile with retention greater than 20 years
- Automatic data protection on power loss
- Unlimited write endurance
- Low-current sleep mode
- Dual 3.3v V<sub>DD</sub> / 1.8v V<sub>DDO</sub> power supply
- Tamper Detect function will detect possible data modification from outside magnetic fields.
- Quad Peripheral Interface (QPI) mode is supported to enhance system performance for Execute in Place (XIP) operation.
- MSL Level 3.

### DESCRIPTION

The MR10Q010 is the ideal memory solution for applications that must store and retrieve data and programs quickly using a small number of pins, low power, and choice of a 24-ball BGA or a 16-pin SOIC package. The four I/O's in Quad SPI mode allow very fast reads and writes, making it an attractive alternative to conventional parallel data bus interfaces in next generation RAID controllers, server system logs, storage device buffers, and embedded system data and program memory.

Using Everspin's patented MRAM technology, both reads and writes can occur randomly in memory with no delay between writes.

Standard Serial Peripheral Interface (SPI), Quad SPI and Quad Peripheral Interface (QPI) modes are supported at a clock rate up to 104MHz. XIP operation is supported for Read commands in all three modes.

The MR10Q010 Quad SPI MRAM is organized as 131,072 words of 8 bits.

# **Operational Overview**

Mode	Command Set	Utility Commands	XIP Command Operation	
SPI Mode	Read 40MHz. Write, Fast Read 104MHz	Write Enable/Disable, Sleep Mode, Read/Write Status Register, Tamper Detect, Read Device ID, Enable QPI Mode	Fast Read	
Quad SPI Mode	Quad I/O mode Read/Write data, or both address and data	None.	Fast Read Quad Output, Fast Read Quad Address and Data	
QPI Mode	Enables command instruction entry in quad I/O mode. (2 clocks)	Disable QPI Mode.	Fast Read, Fast Read Quad Output, Fast Read Quad Address and Data	





16-SOIC



24-BGA



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### **OVERVIEW**

The Serial Peripheral Interface, SPI, is becoming increasingly popular in system design due to the reduced pin count of the serial interface and increasing data bandwidth offered when compared against x8 or x16 parallel interface architectures. The SPI interface has evolved from a single data line to a four data line, or quad architecture. This interface provides a data bandwidth in excess of 50Mbytes/sec.

SPI is currently well-established in microcontroller/microprocessor based systems. The Everspin family of single I/O SPI MRAM is popular in smart meter applications and a variety of other embedded systems. However, the 40MHz limitation with a single data I/O may be too slow for higher performance applications such as the next generation RAID controllers, server system logs, and storage device buffers.

Operating at 52MB/second for both Read and Write the Everspin 1Mb Quad I/O SPI MRAM will meet the needs of these applications. And as a non-volatile memory with over 20 years of data retention, this SPI memory family is equally suited for embedded system data and program memory.

The Quad Peripheral Interface, QPI, mode provides a lower overhead to load commands, which will improve system throughput when operating in an Execute in Place, XIP, environment. This added feature will make the device attractive in embedded applications that store program code in an external memory. QPI effectively increases the effective clock rate and, when combined with Quad SPI instructions, Quad SPI memory performance will outstrip asynchronous parallel memories.

Density	Interface	Voltage (V)	Read/ Write	Active Current R/W (mA)	Standby Current (mA)	Sleep Current (µA)	Package
1 Mb	104MHz Quad SPI	3.3v V <sub>DD</sub> 1.8v V <sub>DDQ</sub>	52MB/sec	60/100	8.0	100	16-SOIC

**Table 1 – Operational Parameters Summary** 

# **Operation in 3.3v Data Bus Systems - Evaluation Board Available**

The Everspin MR10Q010 Quad SPI Serial MRAM requires a  $3.3v\,V_{DD}$  power supply and is designed to operate on a  $1.8v\,I/O$  bus. Adapting the MR10Q010 to operate on a  $3.3v\,$  data bus can be done by interfacing it to the bus through a level translator.

An evaluation board is available to test this adaptation of the MR10Q010 in an existing system. It can be connected to the bus at the board position currently occupied by a SPI or Quad SPI E<sup>2</sup>PROM and operate with the MR10Q010 I/O levels translated for operation on a 3.3v bus.

Contact Everspin for more information about the MR10Q010 3.3v evaluation board and adapting your 3.3v bus system to operate with MR10Q010 MRAM.



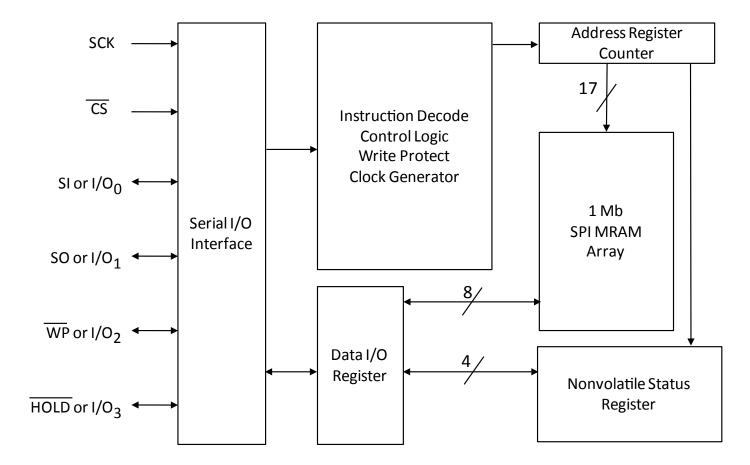


Figure 1 – MR10Q010 Block Diagram



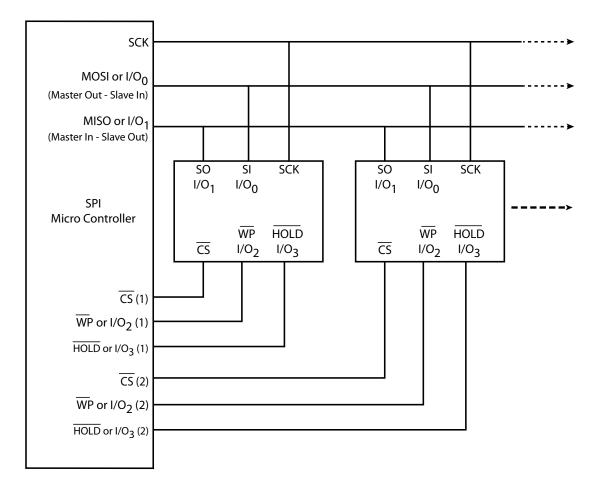
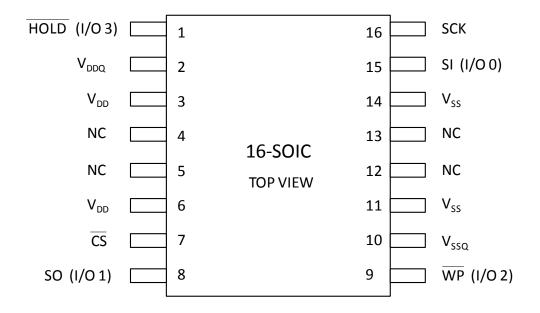


Figure 2 – System Configuration



Figure 3 – 16-SOIC Package Pin Assignments



**Table 2 – 16-SOIC Pin Functions** 

Signal Name	Pin	SPI Mode	Quad SPI Mode <sup>1</sup>	Description		
<u>CS</u>	7	Chip Select	Chip Select	An active low chip select for the serial MRAM. When chip select is high, the memory is powered down to minimize standby power, inputs are ignored and the serial output pin is Hi-Z. Multiple serial memories can share a common set of data pins by using a unique chip select for each memory.		
SO (I/O <sub>1</sub> )	8	Serial Output	I/O <sub>1</sub>	SPI Mode: The data output pin is driven during a read operation and remains Hi-Z at all other times. SO is Hi-Z when HOLD is low. Data transitions on the data output occur on the falling edge of SCK.  Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.		
	Table continues on next page.					



# **16-SOIC Pin Functions - Continued**

Signal Name	Pin	SPI Mode	Quad SPI Mode <sup>1</sup>	Description
WP (I/O <sub>2</sub> )	9	Write Protect	I/O <sub>2</sub>	SPI Mode: A low on the write protect input prevents write operations to the Status Register.  Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.
V <sub>SS</sub>	11, 14	Ground	Ground	Power supply ground pin.
V <sub>SSQ</sub>	10	Ground	Ground	I/O Voltage ground pin.
SI (I/O <sub>0</sub> )	15	Serial Input	I/O <sub>0</sub>	SPI Mode: All data is input to the device through this pin. This pin is sampled on the rising edge of SCK and ignored at other times. SI can be tied to SO to create a single bidirectional data bus if desired.  Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.
SCK	16	Clock	Clock	Synchronizes the operation of the MRAM. The clock can operate up to 104 MHz to shift commands, address, and data into the memory. Inputs are captured on the rising edge of clock. Data outputs from the MRAM occur on the falling edge of clock. The serial MRAM supports both SPI Mode 0 (CPOL=0, CPHA=0) and Mode 3 (CPOL=1, CPHA=1). In Mode 0, the clock is normally low. In Mode 3, the clock is normally high. Memory operation is static so the clock can be stopped at any time.
HOLD (I/O <sub>3</sub> )	1	HOLD	I/O <sub>3</sub>	SPI Mode: A low on the HOLD pin interrupts a memory operation for another task. When HOLD is low, the current operation is suspended. The device will ignore transitions on the CS and SCK when HOLD is low. All transitions of HOLD must occur while CS is low.  Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.
V <sub>DD</sub>	3, 6	Power Supply	Power Supply	Power supply voltage from +3.0 to +3.6 volts.
V <sub>DDQ</sub>	2	I/O Bus Power Supply	I/O Bus Power Supply	I/O Bus supply voltage from +1.7 volts to +1.9 volts.



# Figure 4 - 24-BGA Package Ball Assignments

1 2 3 4 5

NC NC NC NC NC

NC SCK V<sub>SS</sub> V<sub>DD</sub> NC

NC CS NC WP NC

NC SO SO HOLD NC

NC NC NC NC NC

- 24-ball BGA package.
- 8mm x 6mm package outline.
- Serial NOR Flash pinout compatible.
- $V_{DDO}$  on ball E4 to support 1.8v I/O.
- No V<sub>SSO</sub> ball.

Table 3 – 24-BGA Ball Functions

Signal Name	Ball	SPI Mode	Quad SPI Mode <sup>1</sup>	Description		
<u>CS</u>	C2	Chip Select	Chip Select	An active low chip select for the serial MRAM. When chip select is high, the memory is powered down to minimize standby power, inputs are ignored and the serial output pin is Hi-Z. Multiple serial memories can share a common set of data pins by using a unique chip select for each memory.		
SO (I/O <sub>1</sub> )	D2	Serial Output	I/O <sub>1</sub>	SPI Mode: The data output pin is driven during a read operation and remains Hi-Z at all other times. SO is Hi-Z when HOLD is low. Data transitions on the data output occur on the falling edge of SCK.  Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.		
	Table continues on next page.					



# 24-BGA Ball Functions - Continued

Signal Name	Ball	SPI Mode	Quad SPI Mode <sup>1</sup>	Description
WD (I/O )	C4	Write Protect	1/0	SPI Mode: A low on the write protect input prevents write operations to the Status Register.
WP (I/O <sub>2</sub> )	C4	Write Protect	I/O <sub>2</sub>	Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.
V <sub>SS</sub>	В3	Ground	Ground	Power supply ground pin.
				SPI Mode: All data is input to the device through this pin. This pin is sampled on the rising edge of SCK and ignored at other times. SI can be tied to SO to create a single bidirectional data bus if desired.
SI (I/O <sub>0</sub> )	D3	O3 Serial Input I/O 0		Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.
SCK	B2	Clock	Clock	Synchronizes the operation of the MRAM. The clock can operate up to 104 MHz to shift commands, address, and data into the memory. Inputs are captured on the rising edge of clock. Data outputs from the MRAM occur on the falling edge of clock. The serial MRAM supports both SPI Mode 0 (CPOL=0, CPHA=0) and Mode 3 (CPOL=1, CPHA=1). In Mode 0, the clock is normally low. In Mode 3, the clock is normally high. Memory operation is static so the clock can be stopped at any time.
HOLD	D4	HOLD	I/O <sub>3</sub>	SPI Mode: A low on the HOLD pin interrupts a memory operation for another task. When HOLD is low, the current operation is suspended. The device will ignore transitions on the CS and SCK when HOLD is low. All transitions of HOLD must occur while CS is low.
(I/O <sub>3</sub> )	(I/O <sub>3</sub> )		3	Quad SPI Mode: Bidirectional I/O to serially write instructions, addresses or data to the device on the rising edge of SCK or read data output from the device on the falling edge of SCK.
V <sub>DD</sub>	B4	Power Supply	Power Supply Power supply voltage from +3.0 to +3.6 volts.	
V <sub>DDQ</sub>	E4	I/O Bus Power Supply	I/O Bus Power Supply	I/O Bus supply voltage from +1.7 volts to +1.9 volts.



### STATUS REGISTER

The status register consists of the 8 bits shown in Table 3 below.

The Status Register Write Disable bit (SRWD, Bit 7) is used in conjunction with the Write Enable Latch (WEL, bit 1) and the Write Protection pin (WP) to provide hardware memory block protection. Their usage for memory block protection is defined in "Table 5 – Memory Protection Modes". The Status Register Write Disable bit is non-volatile and will remain set whenever power is removed from the memory. The WEL bit (Bit 7) is volatile and set by the Write Enable command. It is set to "0" at power up and reset to "0" when recovering from a loss of power.

The status of memory block protection is indicated by the states of bits BP0 and BP1 (Bits 2 and 3) and are also defined in "Table 5 – Memory Protection Modes" on page 15. BP0 and BP1 are non-volatile and remain set if power is removed from the memory.

The QPI Mode bit (Bit 6) indicates whether the memory is in QPI mode or not. Its value is set when the Enable QPI (EQPI) or Disable QPI (DQPI) commands are invoked. Logic "1" indicates QPI mode is enabled. The QPI Mode Bit is volatile and set to "0" at power up and reset to "0" when recovering from a loss of power.

The fast writing speed of the MR10Q010 does not require write status bit information (Normally Bit 0). The state of reserved bits 4, 5, and 0 can be modified by the user but do not affect memory operation.

All bits in the status register are pre-set at the factory to the "0" state.

Non-reserved Status Register bits are non-volatile with the exception of the WEL and QPI Mode which are reset to 0 upon power cycling.

Bit 7 Bit 6 Bit 5 Bit 4 Bit 3 Bit 2 Bit 1 Bit 0 SRWD OPI Mode BP1 BP0 WEL R2 R1 R0 (Non-Volatile) (Non-Volatile) (Non volatile) (Volatile) (Volatile)

**Table 4 – Status Register Bit Definitions** 

### Bit Definitions:

- 7 SRWD Status Register Write Disable
- 6 QPI Mode bit. Logic 1 = The device is in QPI Mode. Set by the Enable QPI (page 40) and Disable QPI Commands (page 41). Cannot be modified by the Write Status Register Command (page 21). Reset to "0" upon any power cycling.
- 5 R2 Reserved bit 2
- 4 R1 Reserved bit 1
- 3 BP1 Block Protect bit 1
- 2 BPO Block Protect bit 0
- 1 WEL Write Enable Latch bit. Set by the Write Enable (page 19) Command. Reset to "0" upon any power cycling.
- 0 R0 Reserved bit 0. This is the "Write in Progress" bit for many memory devices. For MR10Q010, the "Write in progress" bit (bit 0) is not written by the memory because there is no write delay with MRAM.



# **Memory Protection Modes**

When WEL is reset to 0, writes to all blocks and the status register are protected. When WEL is set to 1, BPO and BP1 determine which memory blocks are protected. While SRWD is reset to 0 and WEL is set to 1, status register bits BPO and BP1 can be modified. Once SRWD is set to 1, WP must be high to modify SRWD, BPO and BP1.

**Status WEL SRWD** WP **Protected Blocks Unprotected Blocks** Register **Protected** Χ **Protected** Protected 0 Χ Writable 1 **Protected** Writable Low **Protected** Writable Protected 1 1 1 1 High **Protected** Writable Writable

**Table 5 – Memory Protection Modes** 

### **Block Protection Modes**

The memory enters hardware block protection when the  $\overline{\text{WP}}$  input is low and the Status Register Write Disable (SRWD) Bit is set to 1. The memory leaves hardware block protection only when the  $\overline{\text{WP}}$  pin goes high. While  $\overline{\text{WP}}$  is low, the write protection blocks for the memory are determined by the status register bits BP0 and BP1 and cannot be modified without taking the  $\overline{\text{WP}}$  signal high again.

If the WP signal is high (independent of the status of SRWD Bit), the memory is in software protection mode. This means that block write protection is controlled solely by the status register BP0 and BP1 block write protect bits and this information can be modified using the WRSR command.

Status Register		Memory Contents			
BP1	BP0	Protected Area	Unprotected Area		
0	0	None	All Memory		
0	1	Upper Quarter	Lower Three-Quarters		
1	0	Upper Half	Lower Half		
1	1	All	None		

**Table 6 – Block Memory Write Protection** 



### SPI COMMUNICATIONS PROTOCOL

The MR10Q010 can be operated in either SPI Mode 0 (CPOL=0, CPHA =0) or SPI Mode 3 (CPOL=1, CPHA=1). For both modes, inputs are captured on the rising edge of the clock and data outputs occur on the falling edge of the clock. When not conveying data, SCK remains low for Mode 0; while in Mode 3, SCK is high. The memory determines the mode of operation (Mode 0 or Mode 3) based upon the state of the SCK when  $\overline{\text{CS}}$  falls.

All memory transactions start when  $\overline{CS}$  is brought low to the memory. The first byte is a command code. Depending upon the command, subsequent bytes of address are input. Data is either input or output. There is only one command performed per  $\overline{CS}$  active period.  $\overline{CS}$  must go inactive before another command can be accepted. To ensure proper part operation according to specifications, it is necessary to terminate each access by raising  $\overline{CS}$  at the end of a byte (a multiple of 8 clock cycles from  $\overline{CS}$  dropping to avoid partial or aborted accesses.

### **SPI MODE COMMANDS**

All memory transactions start when  $\overline{CS}$  is brought low, selecting the memory. The first byte is an 8-bit command code in hexadecimal. The subsequent 24 bits entered are address input. Following the address input (except for the FREAD command) the device will read/write data beginning at the address entered.

For the FREAD command the Mode Byte must be entered following the address. The Mode Byte will either set or reset the XIP mode. See "Execute in Place (XIP) Mode" on page 42.

There is only one command performed per  $\overline{CS}$  active period.  $\overline{CS}$  must go inactive before another command can be accepted. Note: To avoid partial or aborted accesses, memory access must remain active ( $\overline{CS}$  low) for a multiple of 8 clocks from  $\overline{CS}$  going low (the end of a byte.)

At power up, the default operational mode is SPI mode.



# Table 7 - SPI Mode Commands Overview

# **SPI Mode Commands Overview**

Name	Operation	Code	Description			
RDSR	Read Status Register	05h	Returns the contents of the 8 Status Register bits.			
WREN	Write Enable	06h	Sets the Write Enable Latch (WEL) bit in the status register to 1.			
WRDI	Write Disable	04h	Sets the Write Enable Latch (WEL) bit in the status register to 0.			
WRSR	Write Status Register	01h	Writes new values to the entire Status Register.			
READ	Read Data Bytes	03h	Continuously reads data bytes starting at an initial address specified.			
FREAD <sup>1</sup>	Fast Read Data Bytes	0Bh	High-speed READ with XIP operation option.			
WRITE	Write Data Bytes	02h	Continuously writes data bytes starting at an address specified.			
SLEEP	Enter Sleep Mode	B9h	Initiates Sleep Mode.			
WAKE	Exit Sleep Mode	ABh	Terminates Sleep Mode.			
TDET	Tamper Detect	17h	Returns 4 data bytes indicating corrupted or uncorrupted memory.			
RDID	Read ID	4Bh	Returns the Everspin device ID assigned by JEDEC.			

#### Notes:

1. FREAD has the option of using XIP operational mode. See "Execute in Place (XIP) Mode" on page 42 for details of XIP mode with the FREAD command.



# **Read Status Register (RDSR)**

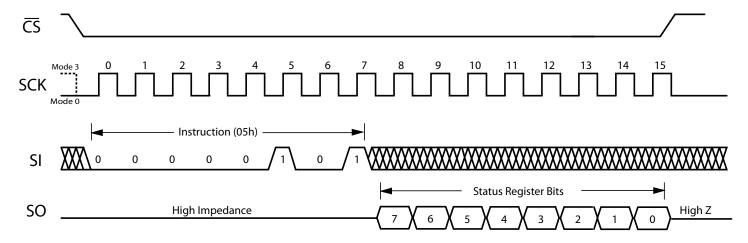
The Status Register can be read at any time to check the status of the Write Enable Latch Bit, status register Write Protect Bit, QPI mode, and the block write protect bits. The RDSR command is entered by driving  $\overline{CS}$  low, sending the command code, and then driving  $\overline{CS}$  high.

See "Table 3 – Status Register Bit Definitions" on page 11 for Status Register Bit definitions.

Figure 5 – Read Status Register (RDSR) Command Operation

		Clock Number <sup>2</sup>					
Name	Operation	0 - 7 <sup>1</sup> 8 - 15 16 - 23 24 - 31 32 - 39 40 - <i>n</i>					
RDSR	Read Status Register	05h	S7-S0 <sup>3</sup>	-	-	-	-

- 1. Clocks 0 7 are the command byte.
- 2. See "AC Timing Parameters" on page 61 for timing requirements.
- 3. See "Table 3 Status Register Bit Definitions" on page 11 for status register bit definitions.





# **Write Enable (WREN)**

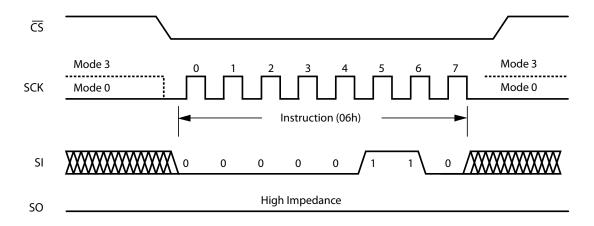
The Write Enable (WREN) command sets the Write Enable Latch Bit (WEL) in the status register (Bit 1). The Write Enable Latch must be set prior to writing in the status register or the memory. The WREN command is entered by driving  $\overline{CS}$  low, sending the command code, and then driving  $\overline{CS}$  high.

See "Table 3 – Status Register Bit Definitions" on page 11 for Status Register Bit definitions.

Figure 6 - Write Enable (WREN) Command Operation

		Clock Number <sup>1</sup>					
Name	Operation	0-7 <sup>2</sup> 8-15 16-23 24-31 32-39 40-n					
WREN	Write Enable	06h	-	-	-	-	-

- 1. See "AC Timing Parameters" on page 61 for timing requirements.
- 2. Clocks 0 7 are the command byte.





# Write Disable (WRDI)

The Write Disable (WRDI) command resets the Write Enable Latch (WEL) bit in the status register (bit 1) to 0. This prevents writes to status register or memory. The WRDI command is entered by driving  $\overline{CS}$  low, sending the command code, and then driving  $\overline{CS}$  high.

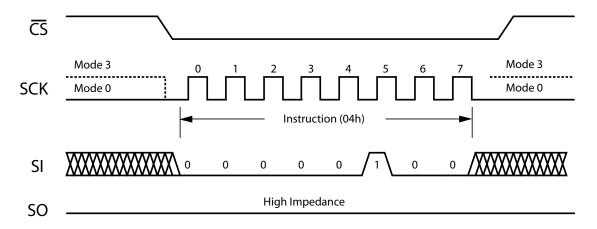
The Write Enable Latch (WEL) is reset to 0 on power-up or when the WRDI command is completed.

See "Table 3 – Status Register Bit Definitions" on page 11 for Status Register bit definitions.

Figure 7 – Write Disable (WRDI) Command Operation

		Clock Number <sup>1</sup>					
Name	Operation	0 - 7 <sup>2</sup> 8 - 15 16 - 23 24 - 31 32 - 39 40 - n					
WRDI	Write Disable	04h	-	-	-	-	-

- 1. See "AC Timing Parameters" on page 61 for timing requirements.
- 2. Clocks 0 7 are the command byte.





## **Write Status Register (WRSR)**

The Write Status Register (WRSR) command allows new values for certain bits to be written to the Status Register. The WRSR command cannot be executed unless the Write Enable Latch (WEL) has been set to 1 by executing a WREN command while pin  $\overline{\text{WP}}$  the SRWD Bit correspond to values that make the status register writable as seen in Table 5 on page 15.

QPI Mode Bit, Bit 6, and the WEL Bit, Bit 0, are set by other commands and cannot be changed by this command.

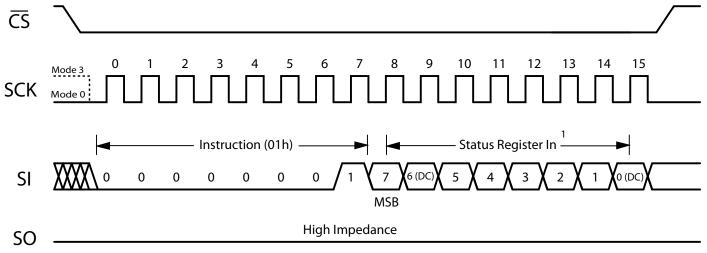
The WRSR command is entered by driving  $\overline{CS}$  low, sending the command code and status register write data byte, and then driving  $\overline{CS}$  high.

Figure 8 – Write Status Register (WRSR) Command Operation

		Clock Number					
Name	Operation	0-7 <sup>1</sup> 8-15 <sup>2</sup> 16-23 24-31 32-39 40- <i>n</i>					
WRSR	Write Status Register	01h	S7-S0	-	-	-	-

#### Notes:

- 1. Clocks 0 7 are the command byte.
- 2. Neither the QPI Mode Bit, Bit 6, or the WEL Bit, bit 0, can be changed by this command.



#### Notes:

1. Neither the QPI Mode Bit, Bit 6, or the WEL Bit, bit 0, can be changed by this command. Treat as Don't Care.



# **Read Data Bytes (READ)**

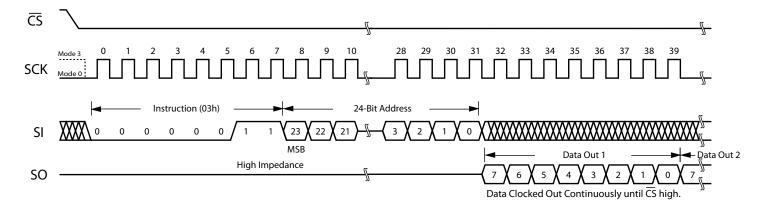
The Read Data Bytes (READ) command allows data bytes to be continuously read starting at an initial address specified by the 24-bit address entry. The data bytes are read out sequentially from memory until the read operation is terminated by bringing  $\overline{\text{CS}}$  high. The entire memory can be read in a single command. The address counter will roll over to 0000H when the address reaches the top of memory.

The READ command is entered by driving  $\overline{\text{CS}}$  low and sending the command code. The memory drives the read data bytes on the SO pin. Reads continue as long as the memory is clocked. (Maximum READ clock frequency 40MHz.) The command is terminated by bringing  $\overline{\text{CS}}$  high.

Clock Number Name **Operation**  $0 - 7^{1}$ 8 - 15 16 - 23 24 - 31 32 - 39 40 - n **READ Read Data Bytes** A23-A16 A15-A8 A7-A0 D7-D0, until CS high 03h

Figure 9 - Read Data Bytes (READ) Command Operation

- 1. Clocks 0 7 are the command byte.
- 2. For timing details, see "Figure 35 Synchronous Data Timing (READ)" on page 63.





## **Fast Read Data Bytes (FREAD)**

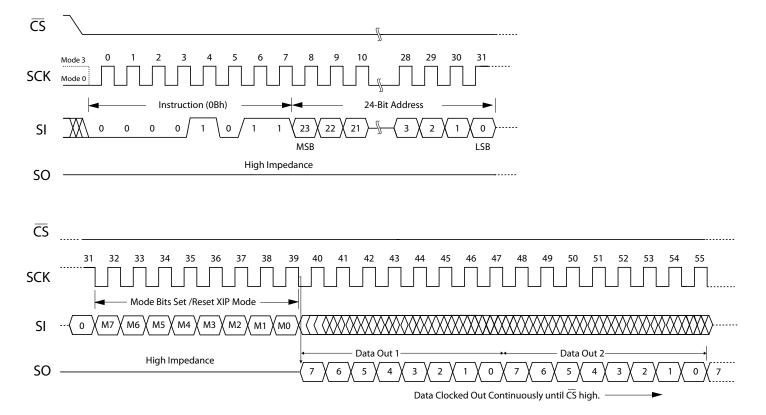
The Fast Read Data Bytes FREAD command is similar to the READ command except that the device can be operated at the highest frequency ( $^f$ SCK = 104MHz) and the command has an XIP operation option. For more detail on the XIP option, see "Table 13 – XIP Mode with FREAD Command" on page 43.

The FREAD command is entered by driving  $\overline{CS}$  low and sending the command code. The memory drives the read data bytes on the SO pin. Reads continue as long as the memory is clocked. The command is terminated by bringing  $\overline{CS}$  high.

Figure 10 – Fast Read Data Bytes (FREAD) Command Operation

				Clock N	lumber		
Name	Operation	0 - 7 <sup>1</sup>	8 - 15	16 - 23	24 - 31	32 - 39	40 - n
FREAD	Fast Read Data Bytes	0Bh	A23-A16	A15-A8	A7-A0	Mode bits <sup>2</sup> (7-0)	D7-D0, until

- 1. Clocks 0 7 are the command byte.
- Mode Byte to Set/Reset XIP operation. Set/Continue XIP Mode = EFh. Reset XIP Mode FFh (exit XIP). See "Execute in Place (XIP) Mode" on page 42 for more detailed information on XIP operation with FREAD.
- 3. For timing details, see "Figure 36 Synchronous Data Timing Fast Read (FREAD)" on page 63.





# Write Data Bytes (WRITE)

The Write Data Bytes (WRITE) command allows data bytes to be written starting at an address specified by the 24-bit address. The data bytes are written sequentially in memory until the write operation is terminated by bringing  $\overline{CS}$  high. The entire memory can be written in a single command. The address counter will roll over to 0000h when the address reaches the top of memory.

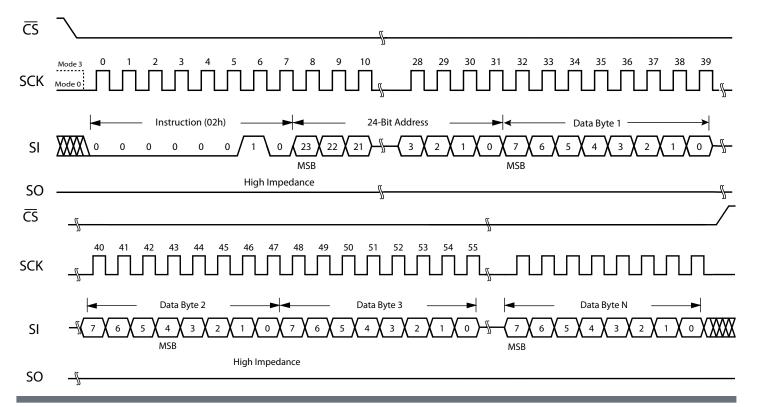
MRAM is a random access memory rather than a page, sector, or block organized memory so it is ideal for both program and data storage. Unlike EEPROM or Flash Memory, MRAM can write data bytes continuously at its maximum rated clock speed without write delays or data polling. Back to back WRITE commands to any random location in memory can be executed without write delay.

The WRITE command is entered by driving  $\overline{CS}$  low, sending the command code, and then sequential write data bytes. Writes continue as long as the memory is clocked. The command is terminated by bringing  $\overline{CS}$  high.

		Clock Number						
Name	Operation	0 - 7 <sup>1</sup>	8 - 15	16 - 23	24 - 31	32 - 39	40 - n	
WRITE	Write Data Bytes	02h	A23-A16	A15-A8	A7-A0	D7-D0, until CS high		

Figure 11 – Write Data Bytes (WRITE) Command Operation

- 1. Clocks 0 7 are the command byte.
- 2. For timing details see "Figure 37 Synchronous Data Timing (WRITE)" on page 64.





## **Enter Sleep Mode (SLEEP)**

The Enter Sleep Mode (SLEEP) command turns off all MRAM power regulators in order to reduce the overall chip standby power to 15  $\mu$ A typical. The SLEEP command is entered by driving  $\overline{CS}$  low, sending the command code, and then driving  $\overline{CS}$  high. The standby current is achieved after time, <sup>t</sup>DP. See "Table 23 – AC Timing Parameters" on page 61 for the <sup>t</sup>DP value.

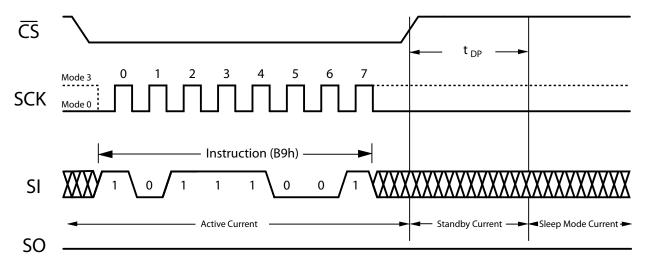
If power is removed when the part is in sleep mode, upon power restoration, the part enters normal standby. The only valid command following SLEEP mode entry is a WAKE command.

**Figure 12 – Enter Sleep Mode (SLEEP) Command Operation** 

		Clock Number					
Name	Operation	0 - 7 <sup>1</sup> 8 - 15 16 - 23 24 - 31 32 - 39 40 - <i>n</i>					
SLEEP	Enter Sleep Mode	B9h	-	-	-	-	-

#### Notes:

1. Clocks 0 - 7 are the command byte.





# **Exit Sleep Mode (WAKE)**

The Exit Sleep Mode (WAKE) command turns on internal MRAM power regulators to allow normal operation. The WAKE command is entered by driving  $\overline{CS}$  low, sending the command code, and then driving  $\overline{CS}$  high. The memory returns to standby mode after <sup>t</sup>RDP. See "Table 23 – AC Timing Parameters" on page 61 for the <sup>t</sup>RPD value.

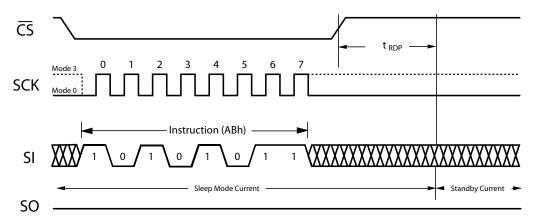
The  $\overline{\text{CS}}$  pin must remain high until the <sup>t</sup>RDP period is over. WAKE must be executed after sleep mode entry and prior to any other command when the device is in Sleep mode.

Figure 13 - Exit Sleep Mode (WAKE) Command Operation

		Clock Number					
Name	Operation	0-7 <sup>1</sup> 8-15 16-23 24-31 32-39 40-n					
WAKE	Exit Sleep Mode	ABh	-	-	-	-	-

#### Notes:

1. Clocks 0 - 7 are the command byte.





# **Tamper Detect (TDET)**

The Tamper Detect command is used to check whether the memory contents have been corrupted by exposure to external magnetic fields. The command is invoked by entering the command code followed by the 8-bit Mode Byte. The device reads dedicated pre-programmed memory bits located around the memory physical array. The contents of these bits are compared to reference bits that are hard programmed into the device via a metal mask. The result of the comparison is returned in 32 status bits of data on SO beginning after the last Mode Byte clock.

All 0's in the 32 TDET status bits indicates that the tamper check bits are correct against the reference bits and the memory has not been corrupted. Presence of any 1's in the 32-bit string indicates that at least one of the check bits does not match its reference bit and the memory contents have likely been corrupted.

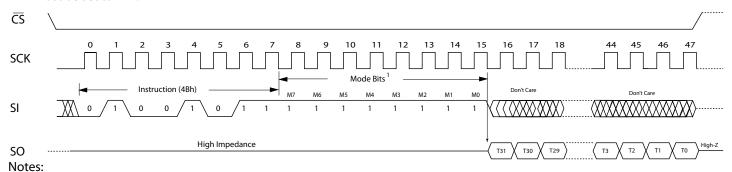
Following  $\overline{CS}$  high, any new command can be entered on the next access, except another TDET command. If it is necessary to immediately enter another TDET command, a Tamper Detect Exit (TDETX) command must be issued first to reset the device for another Tamper Detect sequence.

		Clock Number					
Name	Operation	0 - 7 <sup>1</sup>	8 - 15 16 - 47 48 - n				
TDET	Tamper Detect	17h	Mode Byte bits 7 - 0 <sup>3</sup>	T31 - T0 <sup>2</sup>	CS high		

Figure 14 – Tamper Detect (TDET) Command Operation

#### Notes:

- 1. Clocks 0 7 are the command byte.
- 2. 32 Tamper Detect indication bits. Any 1's present in the 32-bit string indicate probable corruption of the memory contents.
- 3. In the TDET command operation, the Mode Byte is used as a time delay to read the check and reference bits. The Mode Byte must be set to FFh.



1. In the TDET command operation, the Mode Byte must be set to FFh.



# **Tamper Detect Exit (TDETX)**

After running a TDET command, any other command can be run as the next command, except another TDET command. If another TDET command is to be run, then the Tamper Detect Exit (TDETX) command must be run first to reset the device. This is necessary *only* if immediately running another TDET command. See "Tamper Detect (TDET)" on page 27.

Figure 15 – Tamper Detect Exit (TDETX) Command Operation

			Clock Number			
Name	Operation	0-7 <sup>1</sup> 8-n <sup>2</sup>				
TDETX	Tamper Detect Exit	07h	CS high. Any command can be entered on next access.			

- 1. Clocks 0 7 are the command byte.
- 2. After  $\overline{CS}$  goes high any other command can be given on the next access.



# Read ID (RDID)

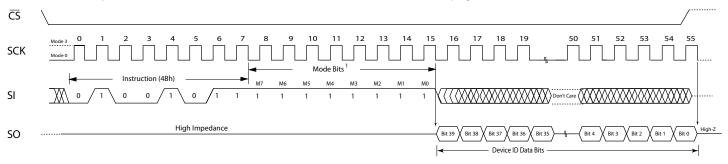
The Read Device ID command (RDID) returns 40 bits of information that identify the Everspin device. The command is invoked with  $\overline{CS}$  low, and sending command code 4Bh on the Serial Input (SI) pin. See "Figure 16 – Read ID (RDID) Command Operation" below. After 8 clocks for the Mode Byte, 40 bits of data uniquely identifying the Everspin device are returned on the Serial Out (SO) pin. See "Table 8 – Device ID for MR10Q010". If  $\overline{CS}$  remains low after reading the 40 ID bits, additional clocks with  $\overline{CS}$  low will return zeros on SO until  $\overline{CS}$  goes high.

Figure 16 - Read ID (RDID) Command Operation

		Clock Number						
Name	Operation	0-7 <sup>1</sup> 8-15 16-23 24-31 32-39 40-n						
RDID	Read ID	4Bh	Mode Byte <sup>2</sup> Bits 7 - 0	Device ID <sup>3</sup> Clocks 16 - 55				

#### Notes:

- 1. Clocks 0 7 are the command byte.
- 2. In the RDID command operation, the Mode Byte is used as a time delay to read the device ID bits. The Mode Byte must be set to FFh.
- 3. For the Everspin device ID codes, see "Table 8 Device ID for MR10Q010" on page 30.



#### Notes:

1. In the RDID command operation, the Mode Byte must be set to FFh.



# **Table 8 - Device ID for MR10Q010**

RDID Device ID for MR10Q010										
Bit #	39 - 24	23 - 20	19 - 16	15 - 12	11 - 8	7 - 4	3 - 0			
Meaning	Manufacturer's ID (JEP 106AH)	Technology	Interface	Speed	Density	Voltage	Die Rev			
MR10Q010	6Bh, eighth bank	Toggle MRAM	Quad IO SPI	104MHz	1 Mb	3.3v V <sub>DD</sub> / 1.8v V <sub>DDQ</sub>	А			
Binary	0000_0111_0110_1011	0001	0001	0001	0001	0001	0001			

Complete Hexadecimal and Binary Device ID for MR10Q010						
Hexadecimal	076B111111					
Binary	0000_0111_0110_1011_0001_0001_0001_0001_0001					



# **QUAD SPI MODE COMMANDS**

Quad SPI commands allow data to be transferred to or from the device at least four times the rate of conventional SPI mode. When using Quad SPI commands the DI and DO pins become bidirectional  $IO_0$  and  $IO_1$ , and the  $\overline{WP}$  and  $\overline{HOLD}$  pins become  $IO_2$  and  $IO_3$  respectively. Address and data information can be input to the device on four IO's and data output can be read from four IO's, offering a significant improvement in continuous and random access transfers. XIP mode operation is available for FRQO and FRQAD commands.

## **Quad SPI Mode Commands Overview**

**Table 9 – Quad SPI Mode Commands Overview** 

Name	Operation	Code	Description
FRQO <sup>1</sup>	Fast Read Quad Output	6Bh	Initial address entry on IO <sub>0</sub> , returns data continuously in Quad SPI Mode on all four I/O. Has XIP operation option.
FWQD	Fast Write Quad Data	32h	Initial address entry on IO <sub>0</sub> , writes data continuously in Quad SPI Mode on all four I/O.
FRQAD <sup>1</sup>	Fast Read Quad Address and Data	EBh	Initial address entry on all four IO's, returns data continuously in quad mode on all four I/O's. Has XIP operation option.
FWQAD	Fast Write Quad Address and Data	12h	Initial address entry on all four IO's, writes data continuously in quad mode on all four I/O's.

#### Notes:

1. XIP mode option. See "Execute in Place (XIP) Mode" on page 42 for details of how to use FRQD and FRQAD in XIP mode.



# **Fast Read Quad Output (FRQO)**

The Fast Read Quad Output (6Bh) command is similar to the Fast Read Output except that a data byte is output on the four I/O pins, requiring only two clocks. An XIP mode is available for this command. See "Table 14 – XIP Operation with FRQO Command" on page 47 for more information about XIP mode operation. The I/O pins should be high impedance prior to the falling edge of the first Mode clock. The FRQO command is entered by driving  $\overline{CS}$  low and sending the command code. The memory drives the read data bytes on the IO pins. Reads continue as long as the memory is clocked. The command is terminated by bringing  $\overline{CS}$  high.

Commmand Operation and Timing next page.

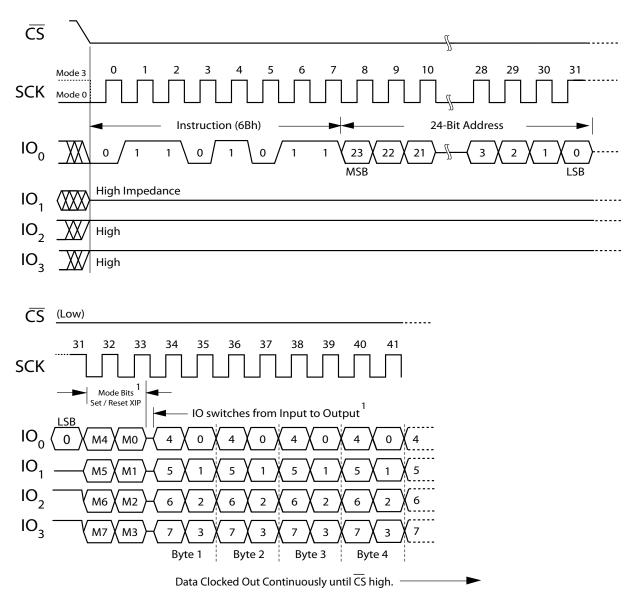


Figure 17 – Fast Read Quad Output (FRQO) Command Operation
--

		Clock Number						
Name	Title	0 - 7 <sup>1</sup>	8 - 15	16 - 23	24 - 31	32 - 33	34 - 35	36 - n
FRQO	Fast Read Quad Output	6Bh	A23-A16	A15 - A8	A7- A0	M7- M0 <sup>2</sup>	D7 - D0, until $\overline{\text{CS}}$ high <sup>3</sup>	

#### Notes:

- 1. Clocks 0 7 are the command byte. All commands and address bits on  $I/O_0$ .
- 2. Mode Byte. See "Execute in Place (XIP) Mode" on page 42 for more information on XIP operation with FRQO.
- 3. Quad Mode data output.  $I/O_0$  switches from Input to Output.  $I/O_{1-3}$  active outputs until  $\overline{CS}$  returns high.  ${}^{t}CSH$  must be observed for valid output when bringing  $\overline{CS}$  high.



#### Note:

1. The I/O pins should be high impedance prior to the falling edge of the second mode clock.



# Fast Read Quad Address and Data (FRQAD)

The Fast Read Quad Address and Data (FRQAD) command is similar to the FRQO command except that the address bits are loaded into the four I/O's, requiring six clocks instead of 24. The data bytes also are read from the four I/O's as shown in Figure 18 below. An XIP operating mode is available for this command. See "Table 15 – XIP Operation with FRQAD Command" on page 51 for more information on the XIP operating mode for this command. The FRQAD command is entered by driving  $\overline{CS}$  low and sending the command code. The memory drives the read data bytes on the IO pins. Reads continue as long as the memory is clocked. The command is terminated by bringing  $\overline{CS}$  high.

Commmand Operation and Timing next page.

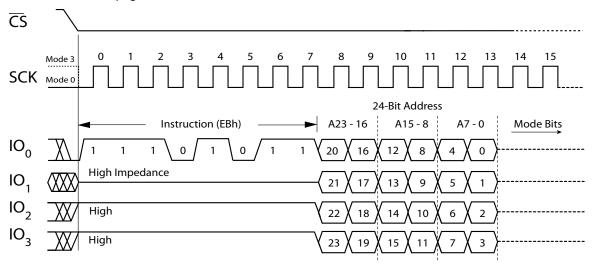


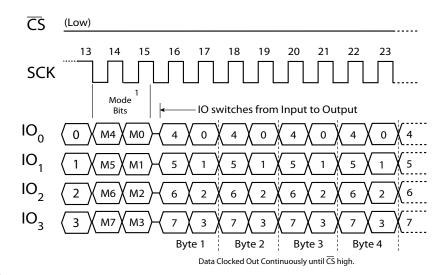
Figure 18 - Fast Read Quad Address and Data (FRQAD) Command Operation

		Clock Number						
Name	Description	0 - 7 <sup>1</sup>	8 - 13 <sup>4</sup>	14- 15 <sup>2</sup>	16 - 17 18 - <i>n</i>			
FRQAD	Fast Read Quad Address and Data	EBh	A23 - A0	M7 - M0 <sup>2</sup>	D7 - D0 every two clocks until $\overline{CS}$ high <sup>3</sup>			

#### Notes:

- 1. Clocks 0 7 are the command byte. All commands and address bits on  $I/O_0$ .
- 2. Mode Byte. See "Execute in Place (XIP) Mode" on page 42 for more information on XIP operation with FRQAD.
- 3. Quad Mode data output.  $I/O_0$  switches from Input to Output.  $I/O_{1-3}$  active outputs until  $\overline{CS}$  returns high.  ${}^{t}CSH$  must be observed for valid output when bringing  $\overline{CS}$  high.
- 4. For timing details, see "Figure 38 Synchronous Data Timing Fast Write Quad Data and Fast Write Quad Address and Data (FWQD and FWQAD)" on page 64.





#### Note:

1. The I/O pins should be high impedance prior to the falling edge of the second mode clock.



## **Fast Write Quad Data (FWQD)**

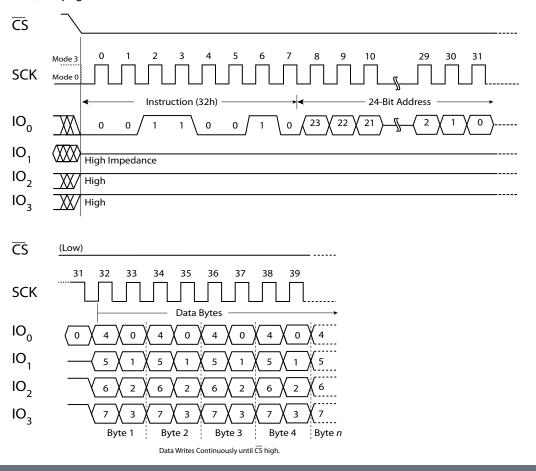
The Fast Write Quad Data FWQD command provides a high speed write capability to the memory using four I/O's for data input. The FWQD command can operate at the highest frequency, fSCK = 104MHz.

The FWQD command is entered by driving  $\overline{\text{CS}}$  low and sending the command code (32h). Data is input on all four I/O's and Writes continue as long as the memory is clocked. The command is terminated by bringing  $\overline{\text{CS}}$  high.

Figure 19 - Fast Write Quad Data (FWQD) Command Operation

		Clock Number						
Name	Title	0-7 <sup>1</sup> 8-15 16-23 24-31 32-33 34-35 36-n						
FWQD	Fast Write Quad Data	32h	A23-A16	A15 - A8	A7- A0	D7 - D0 every two clocks until CS high <sup>2</sup>		

- 1. Clocks 0 7 are the command byte. All commands and address bits on  $I/O_0$ .
- 2. Quad Mode address input.  $I/O_0$  remains input.  $I/O_{1-3}$  active inputs until  $\overline{CS}$  returns high.
- 3. For timing details, see "Figure 38 Synchronous Data Timing Fast Write Quad Data and Fast Write Quad Address and Data (FWQD and FWQAD)" on page 64.





## **Fast Write Quad Address and Data (FWQAD)**

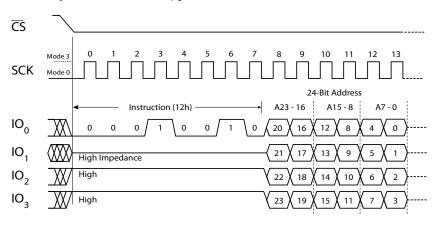
The Fast Write Quad Address and Data Command (FWQAD) provides a very fast write at both the highest frequency and fewest clock cycles. The 24-bit address is input on all four I/O's, reducing the number of clock cycles. The data bytes to be written are also input on all four I/O's following the address bits. The FWQAD command can operate at the highest frequency, <sup>f</sup>SCK = 104MHz.

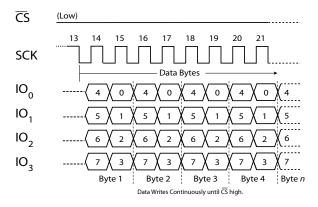
The FWQAD command is entered by driving  $\overline{CS}$  low and sending the command code (12h). Data are input on all four I/O's and Writes continue as long as the memory is clocked. The command is terminated by bringing  $\overline{CS}$  high.

Figure 20 - Fast Write Quad Address and Data (FWQAD) Command Operation

		Clock Number					
Name	Description	0 - 7 <sup>1</sup> 8 - 13 <sup>4</sup> 14 - 15 <sup>2</sup> 16 - n					
FWQAD	Fast Write Quad Address and Data	12h	A23 - A0	D7 - D0 every two clocks until $\overline{\sf CS}$ high <sup>2</sup>			

- 1. Clocks 0 7 are the command byte. All commands and address bits on  $I/O_0$ .
- 2. Quad Mode address input.  $I/O_0$  remains input.  $I/O_{1-3}$  active inputs until  $\overline{CS}$  returns high.







## **QPI MODE**

QPI Mode is designed to reduce command entry overhead in an XIP environment. QPI mode allows the instruction code to be entered on all four I/O's, which reduces the number of clock cycles required for command entry to two from eight. Otherwise, all SPI or Quad SPI commands operate normally.

In SPI or Quad SPI mode device operation is determined by which command is entered. To operate in QPI Mode, the device must be specifically placed into QPI Mode by invoking the Enable QPI Command. When in QPI Mode, the Status Register Bit 6 is set to 1 and will reset to 0 when either power is removed from the device or the QPI Mode is exited with an DQPI command.

At power up, QPI mode is disabled.

**Table 10 – SPI Mode Command Structures in QPI Mode** 

				Clock N	lumber		
Name	Description	0 - 1 <sup>1</sup>	2-9	10 - 17	18 - 25	26 - 33	34 - n
RDSR	Read Status Register	05h	S7-S0	-	-	-	-
WREN	Write Enable	06h	-	-	-	-	-
WRDI	Write Disable	04h	-	-	-	-	-
WRSR	Write Status Register	01h	S7-S0	-	-	-	-
READ	Read Data Bytes	03h	A23-A16	A15-A8	A7-A0	D7-D0 until CS high	
FREAD	Fast Read Data Bytes	08h	A23-A16	A15-A8	A7-A0	M7 - M0 <sup>2</sup>	D7-D0 until CS high
WRITE	Write Data Bytes	02h	A23-A16	A15-A8	A7-A0	D7-D0 un	til CS high
SLEEP	Enter Sleep Mode	B9h	-	-	-	-	-
WAKE	Exit Sleep Mode	ABh	-	-	-	-	-
TDET	Tamper Detect	17h	M7 - M0 <sup>3</sup>	T7 - T0			
RDID	Read ID	4Bh	M7 - M0 <sup>3</sup>	Device ID 40 bits			
DQPI	Disable QPI	FFh	-	-	-	-	-

- 1. Clocks 0 1 are the command bits while in QPI mode.
- 2. M7 M0 is the Mode Byte to Set/Reset XIP Mode. Set XIP Mode = EFh; Reset XIP Mode = FFh.
- 3. Mode Byte must be FFh for TDET and RDID.



## **Table 11 - Quad SPI Mode Command Structures in QPI Mode**

				Clock N	lumber		
Name	Description	0 - 1 <sup>1</sup>	2-9	10 - 17	18 - 25	26 - 27	28 - n
DQPI	Disable QPI	FFh	-	-	-	-	-
FRQO	Fast Read Quad Output	6Bh	A23-A16	A15-A8	A7-A0	M7 - M0 <sup>2</sup>	D7-D0 until
FWQD	Fast Write Quad Data	32h A23-A16 A15-A8 A7-A0 D7-D0 until CS high				til CS high	
				Clock N	lumber		
Name	Description	0 - 1 <sup>1</sup>	2-3	4 - 5	6-7	8 - 9	10 - n
FRQAD	Fast Read Quad Ad- dress and Data	EBh	A23-A16	A15-A8	A7-A0	M7 - M0 <sup>2</sup>	D7-D0 until
FWQAD	Fast Write Quad Ad- dress and Data	12h	A23-A16	A15-A8	A7-A0	D7-D0 un	til CS high

- 1. Clocks 0 1 are the command bits while in QPI mode.
- 2. Mode Byte. Set/Reset XIP operating mode. See "Execute in Place (XIP) Mode" on page 42.



## **Enable QPI (EQPI) Command**

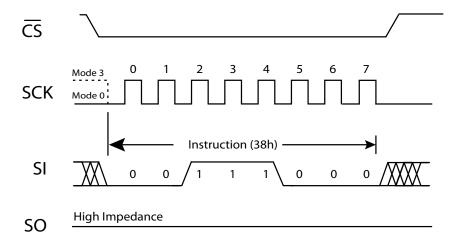
The Enable QPI command is used to enter the device into QPI mode. The command code, 38h, is entered on the DI pin. The command is entered by driving  $\overline{CS}$  low and sending the command code. The command is terminated by driving  $\overline{CS}$  high. When in QPI Mode, the Status Register Bit 6 is set to "1" and the device stays in QPI mode until a power-on reset or the Disable QPI command is entered.

Figure 21 - Enable QPI Mode (EQPI) Command Operation

		Clock Number					
Name	Description	0-7 <sup>1</sup> 8 9-n					
EQPI	Enable QPI Mode	38h CS high In QPI Mode					

#### Notes:

1. Clocks 0 - 7 are the command byte.





## **Disable QPI (DQPI) Command**

The Disable QPI command is used to exit QPI mode and return to the standard SPI/Quad SPI mode and set the Status Register Bit 6 to "0".

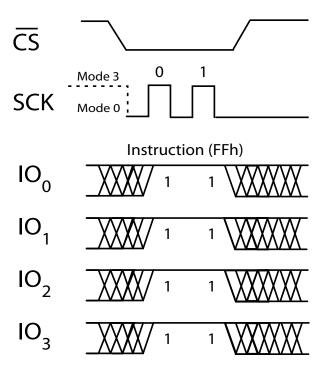
The command code FFh is entered on all four IO's in just two clock cycles as shown below. The command is entered by driving  $\overline{CS}$  low and sending the command code. The command is terminated by driving  $\overline{CS}$  high.

Figure 22 - Disable QPI Mode (DQPI) Command Timing

		Clock Number				
Name	Description	0-1 <sup>1</sup> 2 9-n				
DQPI	Disable QPI Mode	FFh	CS high	Now in SPI / Quad SPI Mode		

### Notes:

1. Clocks 0 - 1 are the command byte on all four I/O.





### **EXECUTE IN PLACE (XIP) MODE**

Execute in Place (XIP) mode provides faster read operations by not requiring a command code for each new starting address during consecutive reads. This improves random access time and eliminates the need to shadow code onto RAM for fast execution. The read commands supported in XIP mode are FREAD (SPI Mode), FRQO, and FRQAD (both Quad SPI Mode commands).

XIP may be run when in QPI mode. Entering or exiting XIP mode will not affect other aspects of QPI mode operation. The device will stay in QPI mode until QPI is disabled with the DQPI command.

XIP mode for these commands is Set or Reset by entering the Mode Byte as shown in "Table 12 – Mode Byte Definitions to Set/Reset XIP Mode" on page 42 below.

In XIP Mode it is possible to perform a series of reads beginning at different addresses without having to load the command code for every new starting address /  $\overline{CS}$  cycle. XIP can be entered or exited during these commands at any time and in any sequence. If it is necessary to perform another operation, not supported by XIP, such as a write, then XIP must be exited before the new command code is entered for the desired operation.

Table 12 - Mode Byte Definitions to Set/Reset XIP Mode

XIP Operation	Hex	M7	M6	M5	M4	М3	M2	M1	МО
Set/Continue	EF	1	1	1	0	1	1	1	1
Reset/Stop (Default)	FF	1	1	1	1	1	1	1	1



### Table 13 - XIP Mode with FREAD Command

Initio	al Command			Clock	Number	
SPI Mode 0 - 7 <sup>1</sup>		0 - 7 <sup>1</sup>	8 - 31	32 - 39	40 - 47	48 - n
QPI Mode 0 - 1 <sup>1</sup>		0 - 1 <sup>1</sup>	3 - 26	27 - 34	35 - 42	43 - n
FREAD	FREAD Fast Read Data Bytes 0Bh		A23-A0	M7 - M0 <sup>2</sup>	D7 - D0	Read Next Byte
			24-bit Address	Set XIP Mode <sup>3</sup>	Read Data Byte	Repeat until CS goes high.

#### Notes:

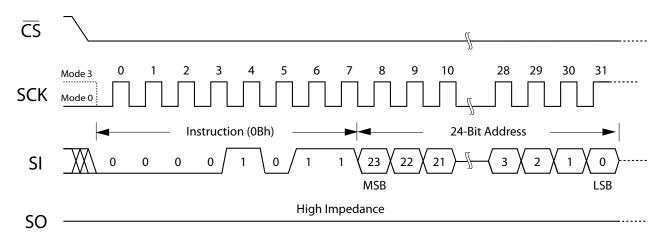
- 1. Command code eight bits.
- 2. Mode Byte will Set/Reset the XIP mode. See "Table 12 Mode Byte Definitions to Set/Reset XIP Mode" on page 42 above for the Set/Reset XIP mode bit definitions.
- 3. If the XIP mode is not Set on the initial command, the command operates in normal SPI Mode until  $\overline{CS}$  high. And, on the next new address, the FREAD the command must be reentered. If XIP Mode has been Set during this initial command entry, the command still operates normally until  $\overline{CS}$  goes high. But on the next  $\overline{CS}$  low, the device remains in FREAD Command mode. No command is entered and the initial read address is entered on the first clock. See the table below.

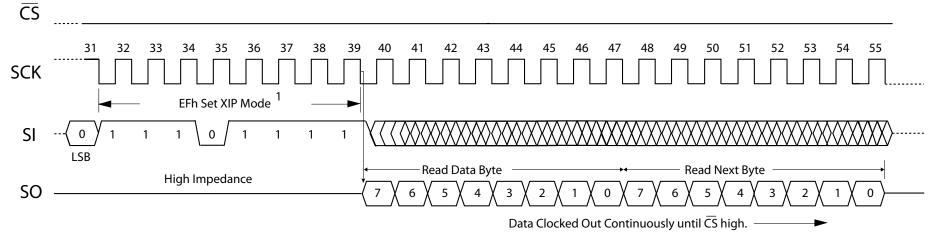
If XIP Se	et - Next CS Low	Clock Number						
Either SPI or QPI Mode		0 - 23 <sup>1</sup>	24 - 31 32 - 39		40 - n			
FREAD Fast Read Data Bytes		A23-A0	A23-A0 M7 - M0 D7 - D0 Read Nex		Read Next Byte			
If XIP Mode is Set, the Command need not be reentered. Initial 24-bit address entry begins on the first clock.		24-bit Address	Set/Reset XIP Mode	Read Data Byte	Repeat until CS goes high.			

- 1. In XIP mode, the last command code sent remains in effect. The starting address is entered beginning on the first clock after CS low.
- 2. If XIP Mode is Reset, the device is out of XIP mode and any command may be entered on the next access.



Figure 23 - FREAD Command- Set XIP Mode - Initial Access

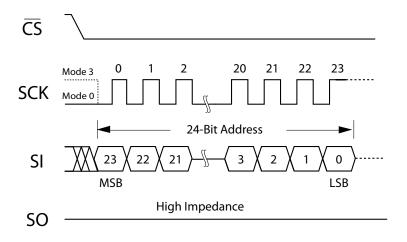


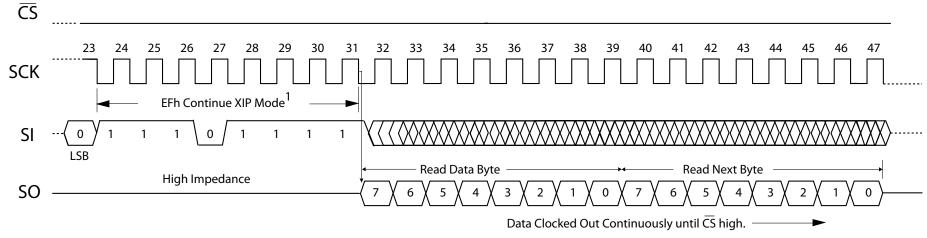


1. Initial FREAD access, XIP mode set for next access.



Figure 24 - FREAD Command - XIP Mode Set - Next Access

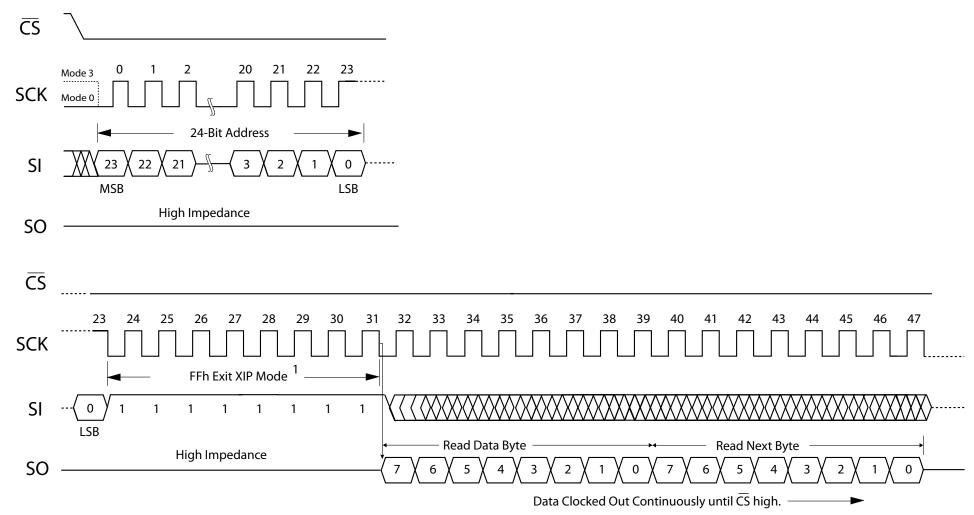




1. Continue FREAD in XIP Mode after this access.



**Figure 25 – FREAD Command - XIP Mode Exit** 



1. XIP Mode code FFh: Reset XIP Mode. After this access a command must be entered on the next access. Any new command may be entered, including the original command.



## **Table 14 - XIP Operation with FRQO Command**

Initio	ıl Command	Clock Number				
Quad SPI Mode 0 - 7 <sup>1</sup>		8 - 31	32 - 33	34 - 35	36 - n	
QPI Mode (		0 - 1 <sup>1</sup>	2 - 25	26 - 27	28 - 29	30 - n
FRQO Fast Read Quad 6Bh		6Bh	A23-A0	M7 - M0 <sup>2</sup>	D7 - D0	Read Next Byte
		24-bit Address	Set XIP Mode <sup>3</sup>	Read Data Byte	Repeat until $\overline{CS}$ goes high.	

#### Notes:

- Command code eight bits.
- 2. Mode Byte entered Set/Reset the XIP mode. See "Table 12 Mode Byte Definitions to Set/Reset XIP Mode" on page 42 above for the Set/Reset XIP mode bit definitions.
- 3. If the XIP mode is not set on the initial command, the command operates in normal SPI Mode until  $\overline{CS}$  high. And, on the next FRQO the command must be reentered. If XIP has been set during this initial command entry, the command still operates normally until  $\overline{CS}$  goes high. But on the next  $\overline{CS}$  low, the device remains in FRQO Command mode, and the initial read address is entered on the first clock. See the table below.

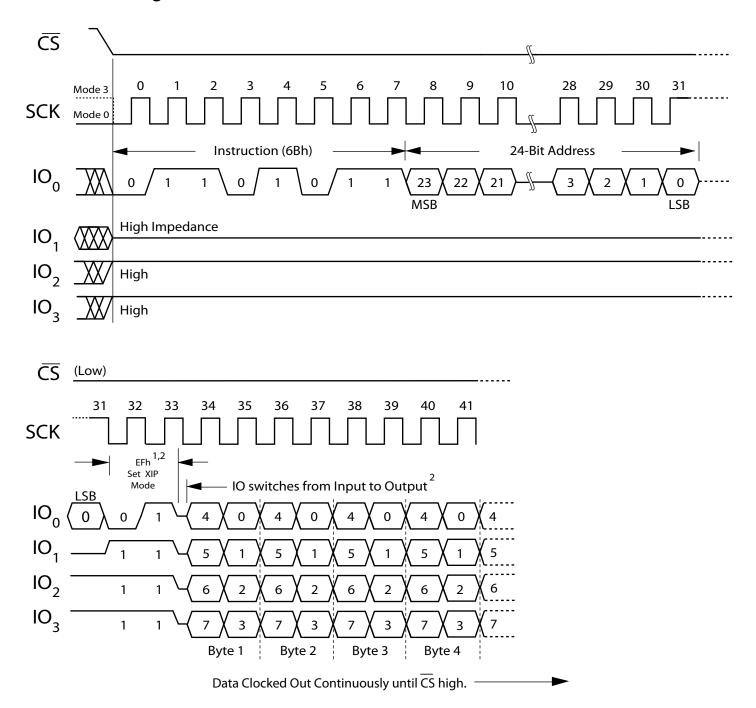
If XIP Se	t - Next CS Low				
Either Quad SPI or QPI Mode		0 - 23	24 - 25	26 - 27	28 - n
FRQO Set Fast Read Quad Output		A23-A0	M7 - M0	D7 - D0	Read Next Byte
If XIP Mode is Set, the Command need not be reentered. Initial 24-bit address entry begins on the first clock.		24-bit Address	Set/Reset XIP Mode	Read Data Byte	Repeat until $\overline{CS}$ goes high.

#### Notes:

1. In XIP operating mode, the last command code sent remains in effect and no command entry is required on the next access.



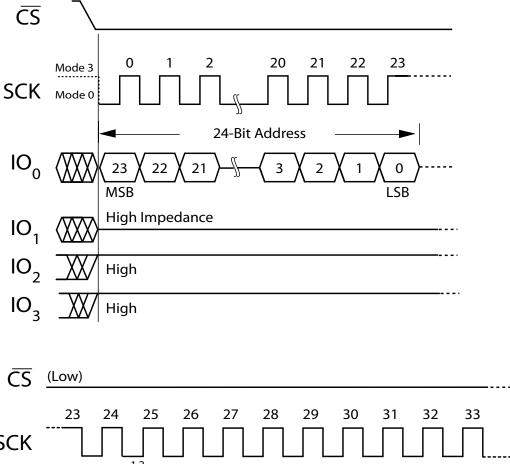
Figure 26 - FRQO Command - Set XIP Mode - Initial Access

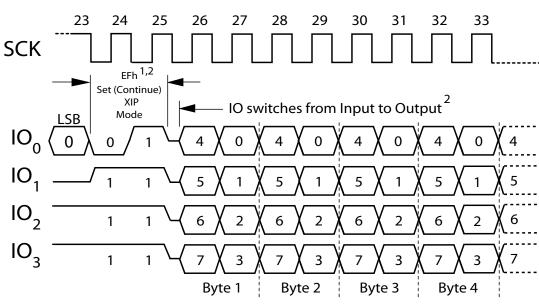


- 1. Initial access, XIP Mode Byte set for next access.
- 2. The I/O pins should be high impedance prior to the falling edge of the second mode clock.



Figure 27 - FRQO Command - XIP Mode Set - Next Access



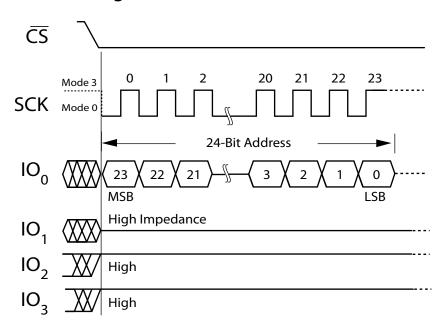


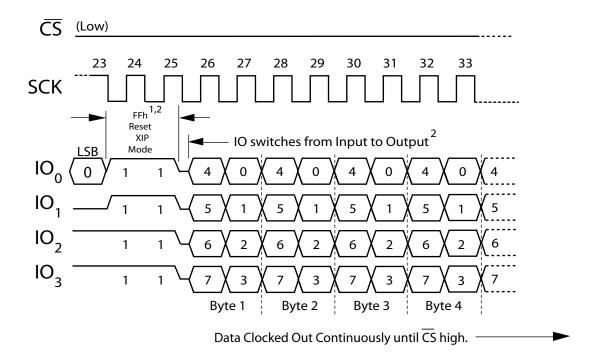
Data Clocked Out Continuously until CS high. ——

- 1. Next access, set to continue XIP Mode.
- 2. The I/O pins should be high impedance prior to the falling edge of the second mode clock.



Figure 28 - FRQO Command - XIP Mode Exit





- 1. XIP Mode Byte FFh. Exit XIP Mode.
- 2. The I/O pins should be high impedance prior to the falling edge of the second mode clock.
- 3. After this access a command must be entered on the next access. Any new command may be entered, including the original command.



## **Table 15 - XIP Operation with FRQAD Command**

Initio	al Command		Clock Number				
Quad SPI Mode 0 - 7 <sup>1</sup>		0 - 7 <sup>1</sup>	8 - 13	14 - 15	16 - 17	18 - n	
QPI Mode 0		0 - 1 <sup>1</sup>	2 - 7	8 - 9	10 - 11	12 - n	
FRQAD Fast Read Quad Ad- dress and Data EBh		EBh	A23-A0	M7 - M0 <sup>2</sup>	D7 - D0	Read Next Byte	
		24-bit Address	Set XIP Mode <sup>3</sup>	Read Data Byte	Repeat until $\overline{CS}$ goes high.		

#### Notes:

- 1. Command code eight bits.
- 2. Mode Byte entered Set/Reset the XIP mode. See "Table 12 Mode Byte Definitions to Set/Reset XIP Mode" on page 42 above for the Set/Reset XIP mode bit definitions.
- 3. If the XIP mode is not set on the initial command, the command operates in normal SPI Mode until CS high. And, on the next FRQAD the command must be reentered. If XIP has been set during this initial command entry, the command still operates normally until CS goes high. But on the next CS low, the device remains in FREAD Command mode, and the initial read address is entered on the first clock. See the table below.

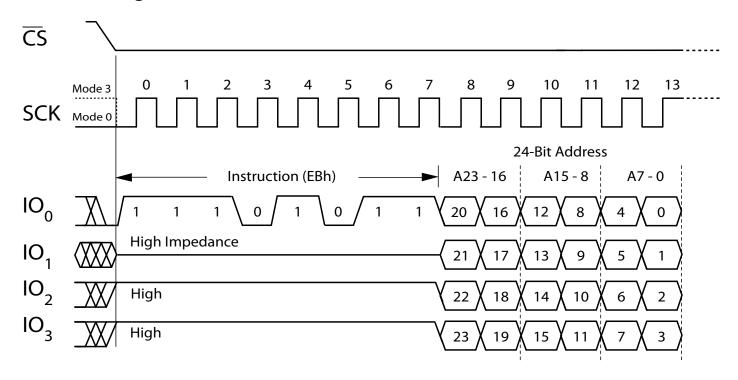
If XIP Se	If XIP Set - Next CS Low				
Either Quad SPI or QPI Mode		0 - 5	6 - 7	8 - 9	10 - n
FRQAD Set Fast Read Quad Address and Data		A23-A0	M7 - M0	D7 - D0	Read Next Byte
If XIP Mode is Set, the Command need not be reentered. Initial 24-bit address entry begins on the first clock.		24-bit Address	Set/Reset XIP Mode	Read Data Byte	Repeat until $\overline{CS}$ goes high.

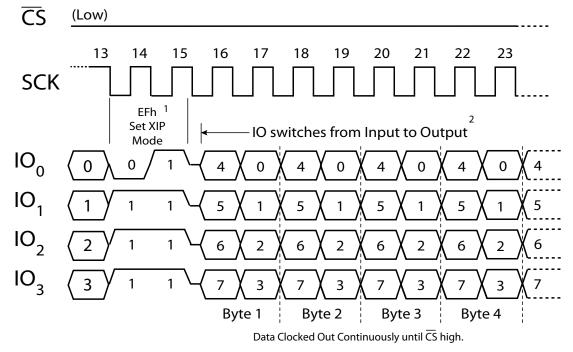
#### Notes:

1. In XIP operating mode, the last command code sent remains in effect and no command entry is required on the next access.



Figure 29 - FRQAD Command - Set XIP Mode - Initial Access

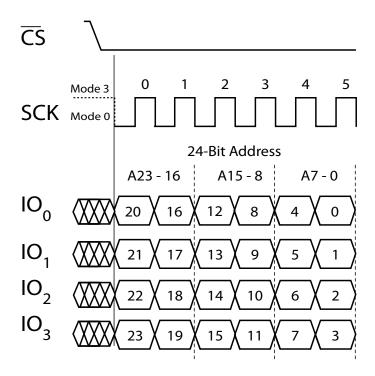


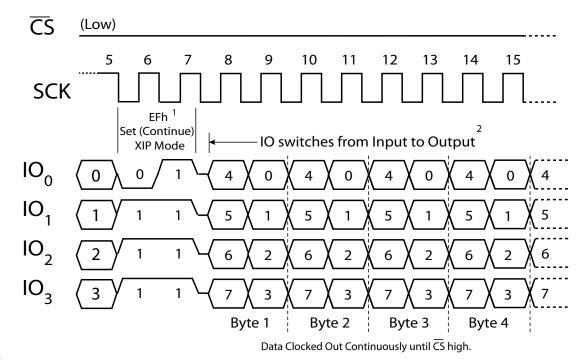


- 1. Initial access, XIP Mode Byte set for next access.
- 2. The I/O pins should be high impedance prior to the falling edge of the second mode clock.



Figure 30 - FRQAD Command - XIP Mode Set - Next Access

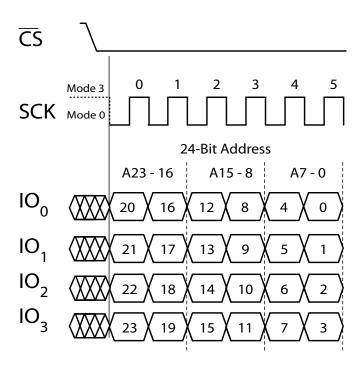


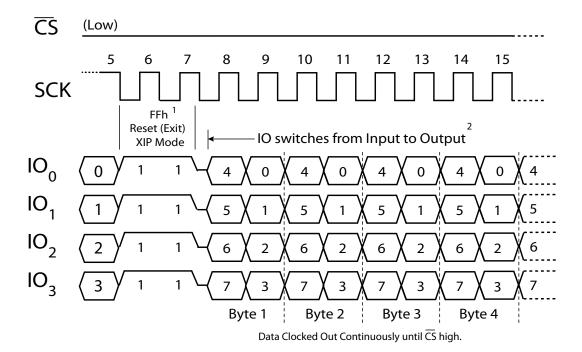


- 1. Next access, set to continue XIP Mode.
- 2. The I/O pins should be high impedance prior to the falling edge of the second mode clock.



Figure 31 - FRQAD Command - XIP Mode Exit





- 1. XIP Mode Byte FFh. Exit XIP Mode.
- 2. The I/O pins should be high impedance prior to the falling edge of the second mode clock.
- 3. After this access a command must be entered on the next access. Any new command may be entered, including the original command.



### **ELECTRICAL SPECIFICATIONS**

This device contains circuitry to protect the inputs against damage caused by high static voltages or electric fields. However, it is advised that normal precautions be taken to avoid application of any voltage greater than maximum rated voltages to these high-impedance (Hi-Z) circuits.

The device also contains protection against external magnetic fields. Precautions should be taken to avoid application of any magnetic field more intense than the maximum field intensity specified in the maximum ratings.

# **Table 16 – Absolute Maximum Ratings**

Permanent device damage may occur if absolute maximum ratings are exceeded. Functional operation should be restricted to recommended operating conditions. Exposure to excessive voltages or magnetic fields could affect device reliability.

Symbol	Parameter	Conditions	Value	Unit
V <sub>DD</sub>	Supply voltage <sup>1</sup>		-0.5 to 4.0	V
V <sub>DDQ</sub>	I/O Bus Supply voltage <sup>1</sup>		-0.5 to 2.4	V
V <sub>IN</sub>	Voltage on any pin <sup>1</sup>		-0.5 to V <sub>DDQ</sub> + 0.5	V
I <sub>оит</sub>	Output current per pin	Output current per pin		
T <sub>BIAS</sub>	Temperature under bias	Temperature under bias Commercial Grade		°C
T <sub>stg</sub>	Storage Temperature		-55 to 150	°C
T <sub>Lead</sub>	Lead temperature during solder (3 minut	e max)	260	°C
H <sub>max_write</sub>	Maximum magnetic field during write	Write	12,000	A/m
H <sub>max_read</sub>	Maximum magnetic field during read or standby	Read or Standby	12,000	A/m

#### Notes:

1. All voltages are referenced to  $V_{SS}$ . The DC value of  $V_{IN}$  must not exceed actual applied  $V_{DD}$  by more than 0.5V. The AC value of  $V_{IN}$  must not exceed applied  $V_{DD}$  by more than 2V for 10ns with  $I_{IN}$  limited to less than 20mA.



# **Table 17 – Operating Conditions**

Symbol	Parameter Conditions		Min	Typical	Max	Unit
$V_{DD}$	Power supply voltage		3.0	3.3	3.6	V
V <sub>DDQ</sub>	I/O Bus Power supply vol	tage	1.7	1.8	2.0	V
V <sub>IH</sub>	Input high voltage		1.4		V <sub>DDQ</sub> + 0.2	V
V <sub>IL</sub>	Input low voltage		-0.2		0.4	V
		Commercial Grade	0		70	°C
T <sub>A</sub>	T <sub>A</sub> Ambient temperature under bias	Industrial Grade	-40		85	°C
		Extended Grade	-40		105	°C

## **Table 18 – DC Characteristics**

Symbol	Parameter	Conditions	Min	Max	Unit
I <sub>IL</sub>	Input leakage current		-	±2	μΑ
I <sub>OL</sub>	Output leakage current		-	±2	μΑ
V <sub>OL</sub>	Output low voltage	I <sub>OL</sub> = 4mA	-	0.4	V
V <sub>OH</sub>	Output high voltage	I <sub>OH</sub> = -100μA	1.4	-	V



# **Table 19 – Power Supply Characteristics**

Symbol	Parameter	Conditions	Typical	Max	Unit
		SPI @ 1 MHz	5.0	11	mA
l <sub>DDR</sub>	Active Read Current	SPI @ 40 MHz	12	17	mA
		Quad SPI @ 104MHz	-	60	mA
		@ 1 MHz	9.0	25	mA
I <sub>DDW</sub>	Active Write Current	@ 40 MHz	28	42	mA
		Quad SPI @ 104MHz	-	100	mA
I <sub>DDQ</sub>	Active V <sub>DDQ</sub> Current	Note 1	-	3	mA
I <sub>SB1</sub>	AC Standby Current ( $\overline{CS}$ High = $V_{IH}$ . No other restrictions on other inputs.)	f≤104MHz	-	8	mA
I <sub>SB1Q</sub>	AC Standby Current on $V_{DDQ}$ supply ( $\overline{CS}$ High = $V_{IH}$ . No other restrictions on other inputs.)	f≤104MHz	ı	1	mA
I <sub>SB2</sub>	CMOS Standby Current (CS High)	f = 0 MHz	-	3	mA
I <sub>SB2Q</sub>	CMOS Standby Current on V <sub>DDQ</sub> Supply (CS High)	f = 0 MHz	-	10	μΑ
I <sub>ZZ</sub>	Standby Sleep Mode Current (CS High)	Sleep Mode	-	100	μΑ

#### Note

## **Table 20 – Capacitance**

Symbol	Parameter	Typical	Max	Unit
C <sub>In</sub>	Control input capacitance <sup>1</sup>	-	6	pF
C <sub>I/O</sub>	Input/Output capacitance <sup>1</sup>	-	8	pF

#### Notes:

1. f = 1.0 MHz, dV = 3.0 V,  $T_A = 25$  °C, periodically sampled rather than 100% tested.

<sup>1.</sup>  $I_{DDQ}$  Conditions: Quad SPI at 104MHz,  $V_{DDQ} = 2.0v$ ,  $V_{IH} = 1.8v$ ,  $V_{IL} = 0v$ .



### **TIMING SPECIFICATIONS**

## **AC Measurement Conditions**

**Table 21 – AC Measurement Conditions** 

Parameter	Value	Unit	
Logic input timing measurement reference level	0.9	V	
Logic output timing measurement reference level	0.9	V	
Logic input pulse levels	0 to 1.6	V	
Input rise/fall time	2 ns		
Output load for low and high impedance parameters	See Figure 32		
Output load for all other timing parameters	See Figure 33		

Figure 32 – Output Load for Impedance Parameter Measurements

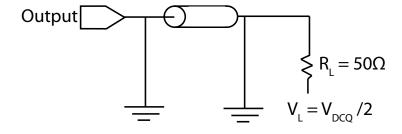
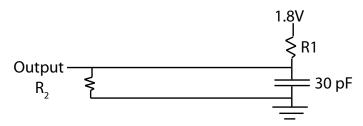


Figure 33 - Output Load for all Other Parameter Measurements





### **Power Up Timing**

To provide protection for data during initial power up, power loss or brownout, whenever  $V_{DD}$  falls below  $V_{WIDD}$  or  $V_{DDQ}$  falls below  $V_{WIDDQ}$  the device cannot be selected ( $\overline{CS}$  is restricted from going low) and the device is inhibited from Read or Write operations. See "Table 22 – Power-Up Delay Minimum Voltages and Timing" below.

### **Power Up Delay Time**

During initial power up or when recovering from brownout or power loss, a power up delay time ( $^{t}PU$ ) must be added to the time required for voltages to rise to their specified minimum voltages ( $V_{DD(min)}$ ) and  $V_{DDQ(min)}$ ) before normal operations may commence. This time is required to insure that the device internal voltages have stabilized. See "Table 22 – Power-Up Delay Minimum Voltages and Timing" below.

<sup>t</sup>PU is measured from the time that  $\underline{both}$   $V_{DD}$  and  $V_{DDQ}$  have reached their specified minimum voltages. See "Figure 34 – Power-Up Timing" for an illustration of the timing.

During initial startup or power loss recovery the  $\overline{CS}$  pin should always track  $V_{DDQ}$  (up to  $V_{DDQ} + 0.2 \, V$ ) or  $V_{IH}$ , whichever is lower, and remain high for the total startup time,  ${}^tPU$ . In most systems, this means that  $\overline{CS}$  should be pulled up to  $V_{DDQ}$  with a resistor. Any logic that drives other inputs or IOs should hold the signals at  $V_{DDQ}$  until normal operation can commence.

Table 22 - Power-Up Delay Minimum Voltages and Timing

Symbol	Parameter	Min	Unit
V <sub>WIDD</sub>	Write Inhibit Voltage	2.2	V
V <sub>WIDDQ</sub>	I/O Write Inhibit Voltage	1.2	V
<sup>t</sup> PU	Power Up Delay Time	400	μs



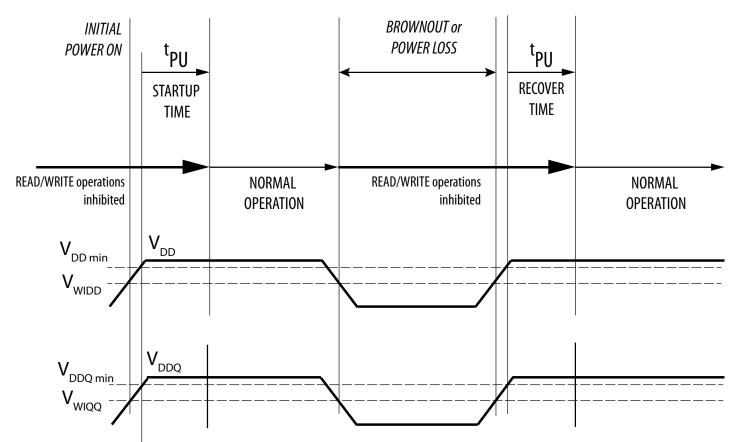


Figure 34 - Power-Up Timing

Note:  $\overline{\mathsf{CS}}$  may not be enabled until <sup>t</sup>PU startup or recovery time is met.



# **AC Timing Parameters**

# **Table 23 – AC Timing Parameters**

Symbol	Parameter	Min	Typical	Max	Unit
f <sub>SCK</sub>	SCK Clock Frequency for all instructions except READ	-	-	104	MHz
SCK	SCK Clock freq for READ	-	-	40	MHz
<sup>t</sup> RI	Input Rise Time	-	-	50	ns
<sup>t</sup> RF	Input Fall Time	-	-	50	ns
<sup>t</sup> WH	SCK High Time except READ	4	-	-	ns
<sup>t</sup> WHR	SCK High Time READ	11	-	-	ns
<sup>t</sup> WL	SCK Low Time except READ	4	-	-	ns
<sup>t</sup> WLR	SCK Low Time READ	12	-	-	ns
Synchrono	us Data Timing see Figures 35, 36, 37, 38				
<sup>t</sup> CSS	CS Setup Time	5	-	-	ns
<sup>t</sup> CSH	CS Hold Time	5	-	ı	ns
<sup>t</sup> SU	Data In Setup Time	2	-	1	ns
<sup>t</sup> H	Data In Hold Time	5	-	1	ns
tV	Output Valid	-	-	7	ns
<sup>t</sup> HO	Output Hold Time	1.5	-	-	ns
<sup>t</sup> CS	CS High Time at end of all Cycles except Writes	10	-	-	ns
<sup>t</sup> CSW	CS High Time at end of Write Cycles	50	-	-	ns



# **AC Timing Parameters - Continued**

Symbol	Parameter	Min	Typical	Max	Unit
HOLD Timin	ng see Figure 39				
<sup>t</sup> HD	HOLD Setup Time	2	-	-	ns
<sup>t</sup> CD	HOLD Hold Time	2	-	-	ns
<sup>t</sup> LZ	HOLD to Output Low Impedance	-	-	12	ns
<sup>t</sup> HZ	HOLD to Output High Impedance	-	-	7	ns
Other Timir	ng Specifications				
<sup>t</sup> WPS	WP Setup To CS Low	5	-	-	ns
<sup>t</sup> WPH	WP Hold From CS High	5	-	-	ns
<sup>t</sup> DP	Sleep Mode Entry Time	-	-	3	μs
<sup>t</sup> RDP	Sleep Mode Exit Time	-	-	400	μs
<sup>t</sup> DIS	Output Disable Time	-	-	7	ns



Figure 35 – Synchronous Data Timing (READ)

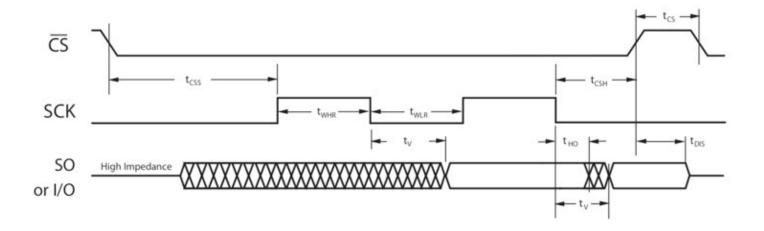


Figure 36 – Synchronous Data Timing Fast Read (FREAD)

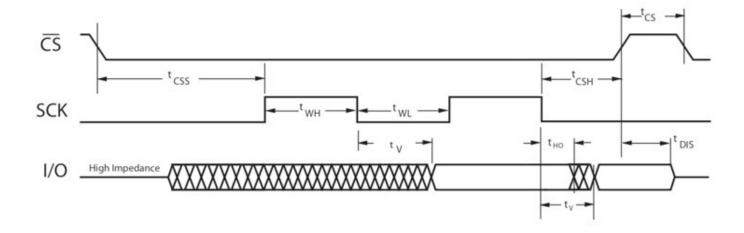




Figure 37 – Synchronous Data Timing (WRITE)

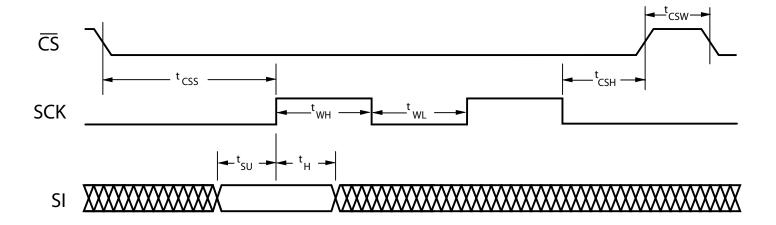
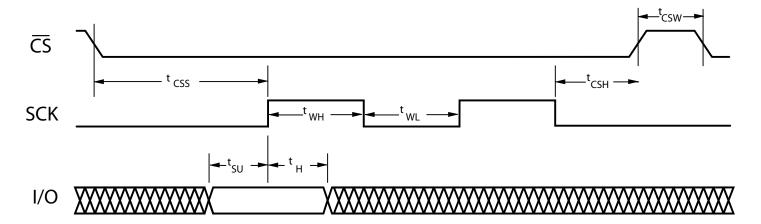
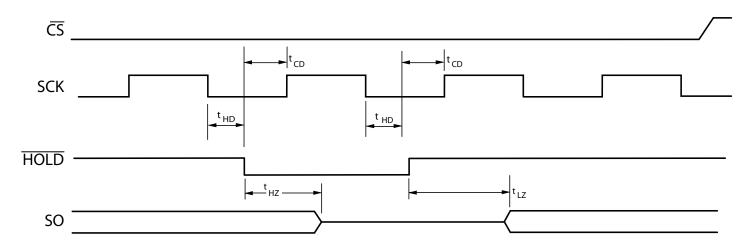


Figure 38 – Synchronous Data Timing Fast Write Quad Data and Fast Write Quad Address and Data (FWQD and FWQAD)





# Figure 39 – HOLD Timing





## **PART NUMBERS AND ORDERING**

**Table 24 – Part Numbering System** 

			Memory	Interface	Density	Revision	Temp	Package	Ship	Grade
Exam	ple Ordering Part	Number	MR	10Q	010		C	SC	R	
MRAM (Toggle)		MR								
104MHz Quad SPI	Family	10Q								
1 Mb		010								
4 Mb		040								
16Mb		160								
No Revision		Blank								
Revision A		Α								
Revision B		В								
Commercial	0 to 70°C	Blank								
Industrial	-40 to 85℃	C								
Extended	-40 to 105℃	V								
16-pin SOIC		SC								
24-ball BGA		MB								
Tray		Blank								
Tape and Reel		R								
<b>Customer Samples</b>		CS								
Mass Production		Blank								

**Table 25 – Ordering Part Numbers** 

Temp Grade	Temperature	Package	Shipping Container	Order Part Number	
		16 5016	Trays	MR10Q010SC	
Camanagaial	0.4- 70%	16-SOIC	Tape and Reel	MR10Q010SCR	
Commercial	0 to 70°C	24.064	Trays	MR10Q010MB	
		24-BGA	Tape and Reel	MR10Q010MBR	
	-40 to 85°C		16 5016	Trays	MR10Q010CSC
Industrial		16-SOIC	Tape and Reel	MR10Q010CSCR	
industriai		24-BGA	Trays	MR10Q010CMB	
		24-DUA	Tape and Reel	MR10Q010CMBR	
		16 6016	Trays	MR10Q010VSC	
Extended	-40 to 105°C	16-SOIC	Tape and Reel	MR10Q010VSCR	
Exterided	-40 to 103 C	24-BGA	Trays	MR10Q010VMB	
		24-DUA	Tape and Reel	MR10Q010VMBR	



# **PACKAGE CHARACTERISTICS**

## **Table 26 – Thermal Resistance 16-pin SOIC**

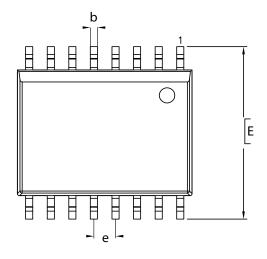
All thermal resistance values are estimated by simulation.

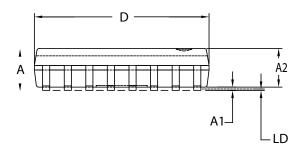
Velocity	T <sub>A</sub> <sup>1</sup>	P <sub>D</sub> <sup>2</sup>	T <sub>J</sub> Max <sup>3</sup>	⊝ <sub>JA</sub> ⁴	⊖ <sub>JB</sub> <sup>5</sup>	Θ <sub>JC</sub> 6
m/s	°C	W	°C		°C/W	
0			71.0	58.1		
1	25	0.702	64.5	49.9	20.6	
2	25	0.792	62.8	47.7	30.6	31.6
3			61.8	46.4	-	

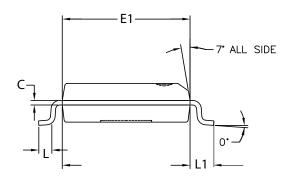
- 1.  $T_A$  Ambient temperature.
- 2.  $P_D$  Power dissipation at maximum  $V_{DD}$  and  $I_{DDW}$ .
- 3. T<sub>I</sub> Max Maximum junction temperature reached at maximum power dissipation.
- 4.  $\Theta_{JA}$  Junction to ambient.
- 5.  $\Theta_{JB}$  Junction to board.
- 6.  $\Theta_{JC}$  Junction to package case.



Figure 40 - 16-SOIC Package Outline







Dimensions next page.

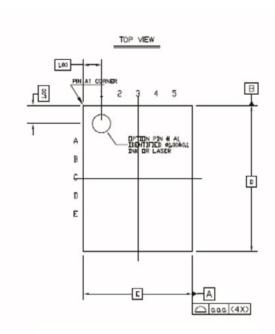


# **16-SOIC Package Outline - Dimensions**

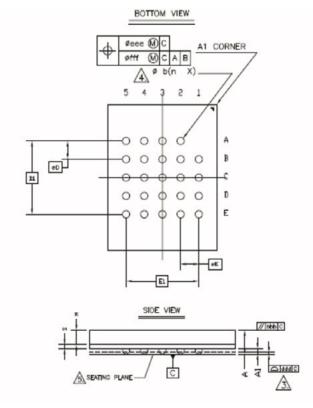
Symbol	JEDEC MS - 013 (AA)			Everspin POD 16L SOIC PKG OUTLINE		
	issue (mm)			DWG. 300 MIL (mm)		
Ref	MIN	NOM	MAX	MIN	NOM	MAX
Α	-	-	2.65	2.46	2.56	2.64
A1	0.10	-	0.30	0.127	0.22	0.29
A2	2.05	-	-	2.29	2.34	2.39
b	0.31	-	0.51	0.35	0.41	0.51
С	0.20	-	0.33	0.23	0.25	0.32
D	10.30 BSC			10.21	10.34	10.46
E	10.30 BSC			10.16	10.31	10.63
E1	7.50 BSC			7.44	7.52	7.59
L	0.40	-	1.27	0.61	0.81	1.02
L1	1.40 REF			N/A		
е	1.27 BSC			1.27 BSC		
Θ	0°	-	8°	0°	5°	8°



Figure 41 – 24 Ball BGA Package Outline



Dimension	Min	Nominal	Max
Package Width, E	5.900	6.000	6.100
Package Lenth, D	7.900	8.000	8.100
Package Thickness, A	1.190	1.270	1.350
Solder Ball Stand-Off, A1	0.220		0.320
Solder Ball Width, b	0.320		0.420
Solder Ball Diameter		0.350	
Solder Ball Pitch, eE		1.000	
Solder ball Pitch, eD		1.000	
package Edge Tolerance, aaa		0.100	
Mold Flatness, bbb		0.200	
Solder Ball Coplanarity, ddd		0.080	
Solder Offset (Package)		0.150	
Solder Offset (Ball)		0.080	
Edge Ball Center to Center, E1		4.000	
Edge Ball Center to Center, D1		4.000	
Ball Count, n		24	



Notes:			
1	Dimensions and tolerances per ASME Y14.5M - 1994.		
2	Solder ball position designation per JESD 95-1, SPP-010.		
<u>_3</u>	This dimension includes stand-off height, packge body thickness and lid height, but does not include attached features, e.g. external heatsink or chip capacitors. An intergral heatslug is not considered an attached feature.		
4	Dimension is measured at the maximum solder ball diameter, parallel to primary Datum C.		
<u>\( \) \</u>	Primary Datum C and the seating plane are defined by the spherical crowns of the solder balls.		
6	All dimensions are in millimeters.		



## **REVISION HISTORY**

Revision	Date	Description of Change
1.7	February 26, 2013	Initial Release Preliminary.
1.8	March 7, 2013	Revision to Table 5. Revision to HOLD timing Table 15. Corrected package illustration.
1.9	May 14, 2013	Added QPI Commands.
2.0	October 24, 2013	Removed QPI Commands, TDET and reference to XIP. These features will be released in a future product revision.
3.0	April 17, 2014	Major revision. Complete restructure of command section. Added QPI Mode, TDET, TDETX commands and XIP operating mode commands, instructions and timing diagrams. Removed Preliminary watermark from all pages. Removed Max and Typical values for V <sub>WIDD</sub> and V <sub>WIDDQ</sub> .
4.0	December 17, 2014	Added I <sub>SB1Q</sub> , I <sub>SB2Q</sub> , I <sub>DDQ</sub> values. Revisions to Command Descriptions for FRQO and FRQAD. Revisions to Note 3 for Command Timing Diagrams for FRQO and FRQAD. Added package thermal resistance table. I <sub>DD</sub> values in Table 8 have been updated.
4.1	March 20, 2015	Revised Table 23: <sup>t</sup> CS updated. <sup>t</sup> V (min) now unspecified. <sup>t</sup> HO (min) revised to 1.5ns.
4.2	May 19, 2015	Revised Everspin contact information.
4.3	June 11, 2015	Corrected Japan Sales Office telephone number.
5.0	August 12, 2015	Added 6x8mm 24-ball BGA package outline and dimensions.
5.1	January 26, 2017	Table 23: Revised <sup>t</sup> WHR = 11ns; <sup>t</sup> WLR = 12ns. 16-SOIC package options released to MP. 24-BGA now qualified.
5.2	February 1, 2017	Figures 35 and 36 - Synchronous Data Timing. Added timing detail for <sup>t</sup> V and <sup>t</sup> HO.
5.3	December 4, 2017	Figure 40 updated with new dimensions
5.4	January 26, 2018	Added extended temperature range to the data sheet.
5.5	March 15, 2018	Added extended range to Table 17
5.6	June 1, 2018	Updated table 24